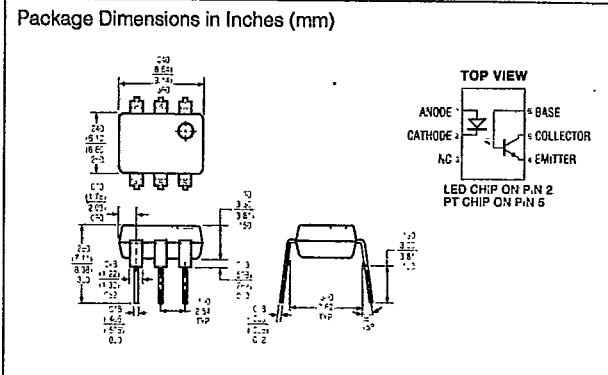
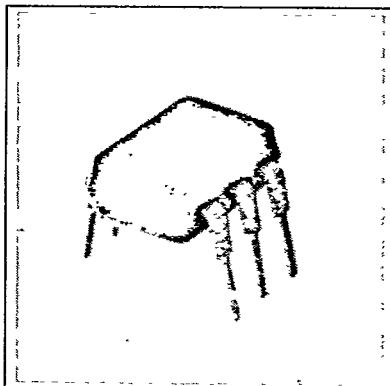


**SIEMENS****IL1/2/5****PHOTOTRANSISTOR  
OPTOCOUPLER****T-41-83****FEATURES**

- Current Transfer Ratio @  $I_F = 10 \text{ mA}$   
IL1 - 20% Min.  
IL2 - 100% Min.  
IL5 - 50% Min.
- High Collector-Emitter Voltage  
IL1 -  $BV_{CEO} = 50 \text{ V}$   
IL2, IL5 -  $BV_{CEO} = 70 \text{ V}$
- Field-Effect Stable by TRansparent IOn Shield (TRIOS)\*
- Double Molded Package Offers Withstand Test Voltage  
7500 VAC<sub>PEAK</sub>, 1 sec.  
4420 VAC<sub>RMS</sub>, 1 min.
- UL Approval #E52744
- VDE Approvals 0883/6.80, 0804/1.83

**DESCRIPTION**

The IL1/2/5 are optically coupled isolated pairs employing GaAs infrared LEDs and silicon NPN phototransistor. Signal information, including a DC level, can be transmitted by the drive while maintaining a high degree of electrical isolation between input and output. The IL1/2/5 are especially designed for driving medium-speed logic and can be used to eliminate troublesome ground loop and noise problems. These couplers can be used also to replace relays and transformers in many digital interface applications such as CRT modulation.

See Appnote 45, "How to Use Optocoupler Normalized Curves."

TRansparent IOn Shield.

**Maximum Ratings**

<b>Emitter</b>	
Reverse Voltage	..... 6 V
Forward Current	..... 100 mA
Surge Current	..... 2.5 A
Power Dissipation	..... 200 mW
Derate Linearly from 25°C	..... 2.6 mW/°C
<b>Detector</b>	
Collector-Emitter Reverse Voltage	
IL1	..... 50 V
IL2, IL5	..... 70 V
Emitter-Base Reverse Voltage	..... 7 V
Collector-Base Reverse Voltage	..... 70 V
Collector Current	..... 50 mA
Collector Current ( $t < 1 \text{ ms}$ )	..... 400 mA
Power Dissipation	..... 200 mW
Derate Linearly from 25°C	..... 2.6 mW/°C
<b>Package</b>	
Storage Temperature	..... -40°C to +150°C
Operating Temperature	..... -40°C to +100°C
Junction Temperature	..... 100°C
Soldering Temperature (in a 2 mm distance from case bottom)	..... 260°C
Package Power Dissipation	..... 250 mW
Derate Linearly from 25°C	..... 3.3 mW/°C
UL Withstand Test Voltage (PK) ( $t=1 \text{ sec.}$ )	..... 7500 VDC/5300 VAC <sub>RMS</sub>
VDE Isolation Test Voltage In Accordance with DIN 57883/6.80	..... 5300 VDC/3750 VAC <sub>RMS</sub>
Creepage Path	..... 8 min mm
Clearance Path	..... 7 min mm
Tracking Index According to VDE 0303	..... KB 100/A
Working Voltage	..... 1700 VAC <sub>RMS</sub>
Insulation Resistance	..... 10 <sup>11</sup> Ω

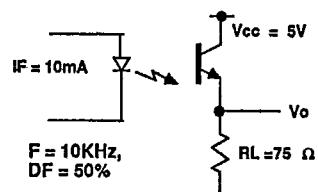
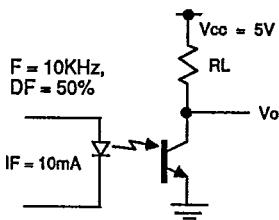
Characteristics						Characteristics (Cont.)					
	Symbol	Min.	Typ.	Max.	Unit		Symbol	Min.	Typ.	Max.	Unit
<b>Emitter</b>						<b>Package Transfer Characteristics (Cont.)</b>					
Forward Voltage ( $I_f=60 \text{ mA}$ )	$V_F$		1.25	1.65	V	IL2					
Breakdown Voltage ( $I_h=10 \mu\text{A}$ )	$V_{BR}$	6	30		V	Saturated Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=0.4 \text{ V}$ )	$CTR_{CESAT}$		170		%
Reverse Current ( $V_R=5 \text{ V}$ )	$I_R$		0.01	10	$\mu\text{A}$	Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=10 \text{ V}$ )	$CTR_{CE}$	100	200	500	%
Capacitance ( $V_R=0 \text{ V}, f=1 \text{ MHz}$ )	$C_0$		40		pF	Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=9.3 \text{ V}$ )	$CTR_{CB}$		0.35		%
Thermal Resistance Junction to Lead	$R_{THUL}$		750		$^{\circ}\text{C}/\text{W}$	<b>IL5</b>					
<b>Detector</b>						Saturated Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=0.4 \text{ V}$ )	$CTR_{CESAT}$		100		%
Capacitance ( $V_{ce}=5 \text{ V}, f=1 \text{ MHz}$ )	$C_{CE}$		6.8		pF	Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=10 \text{ V}$ )	$CTR_{CE}$	50	130	400	%
( $V_{ce}=5 \text{ V}, f=1 \text{ MHz}$ )	$C_{CA}$		8.5		pF	Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=9.3 \text{ V}$ )	$CTR_{CB}$		0.3		%
( $V_{ce}=5 \text{ V}, f=1 \text{ MHz}$ )	$C_{CB}$		11		pF	<b>Isolation and Insulation</b>					
Collector-Emitter Leakage Current ( $V_{ce}=10 \text{ V}$ )	$I_{CEO}$		5	50	nA	Common Mode Rejection Output High ( $V_{ce}=50 \text{ V}_{pp}, R_L=1 \text{ k}\Omega, I_f=0 \text{ mA}$ )	$CMH$		5000		$\text{V}/\mu\text{s}$
Collector-Emitter Saturation Voltage ( $I_{ce}=1 \text{ mA}, I_g=20 \mu\text{A}$ )	$V_{CE(SAT)}$		0.25	0.4		Common Mode Rejection Output Low ( $V_{ce}=50 \text{ V}_{pp}, R_L=1 \text{ k}\Omega, I_f=10 \text{ mA}$ )	$CML$		5000		$\text{V}/\mu\text{s}$
Base-Emitter Voltage ( $V_{ce}=10 \text{ V}, I_g=20 \mu\text{A}$ )	$V_{BE}$		0.65		V	Common Mode Coupling Capacitance	$C_{CK}$		0.01		pF
DC Forward Current Gain ( $V_{ce}=10 \text{ V}, I_g=20 \mu\text{A}$ )	HFE	200	650	1800		Package Capacitance ( $V_{ce}=0 \text{ V}, f=1 \text{ MHz}$ )	$C_{IO}$	0.8			pF
Saturated DC Forward Current Gain ( $V_{ce}=0.4 \text{ V}, I_g=20 \mu\text{A}$ )	$HFE_{SAT}$	120	400	600		Insulation Resistance ( $V_{ce}=500 \text{ V}$ )	$R_i$	$5^{+0}$	$10^{-14}$		$\Omega$
Thermal Resistance Junction to Lead	$R_{THUL}$		500		$^{\circ}\text{C}/\text{W}$	Dielectric Leakage Current ( $V_{io}=4420 \text{ AC}_{(\text{RMS})} 1 \text{ min., } 60 \text{ Hz}$ )	$I_{IO}$		3.3	10	$\mu\text{A}$
<b>Package Transfer Characteristics</b>						( $V_{io}=6250 \text{ VDC, 1 min.}$ )			0.5	10	$\mu\text{A}$
<b>IL1</b>						( $V_{io}=5304 \text{ AC}_{(\text{RMS})} 1 \text{ sec., } 60 \text{ Hz}$ )			4	10	$\mu\text{A}$
Saturated Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=0.4 \text{ V}$ )	$CTR_{CESAT}$		75		%	( $V_{io}=7500 \text{ VDC, 1 sec.}$ )			0.6	12	$\mu\text{A}$
Current Transfer Ratio (Collector-Emitter) ( $I_f=10 \text{ mA}, V_{ce}=10 \text{ V}$ )	$CTR_{CE}$	20	80	300	%						
Current Transfer Ratio (Collector-Base) ( $I_f=10 \text{ mA}, V_{ce}=9.3 \text{ V}$ )	$CTR_{CB}$		0.25		%						

5-33

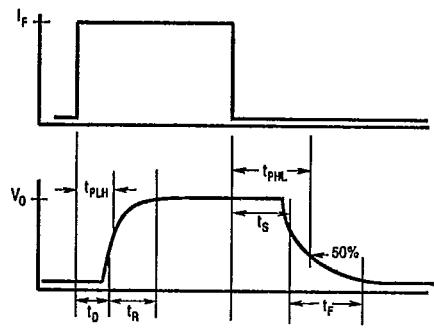
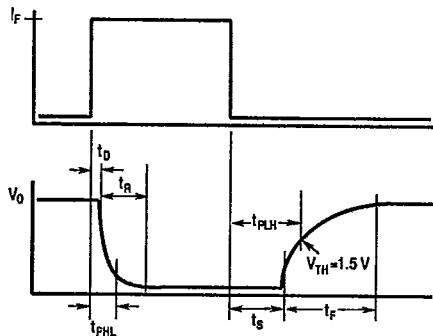
Optocouplers  
(Optoisolators)

IL1/2/5

T-41-83

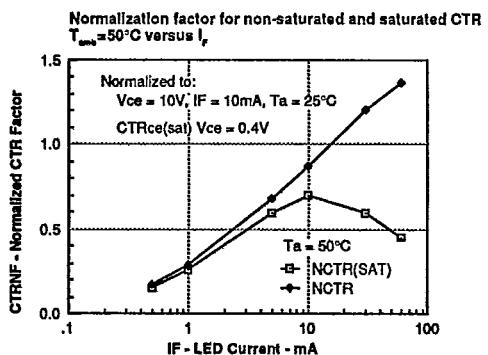
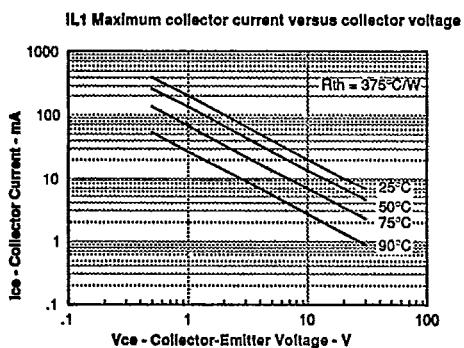
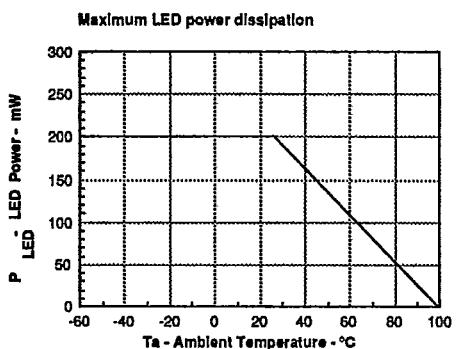
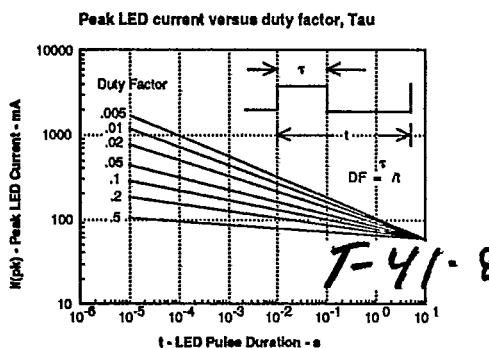
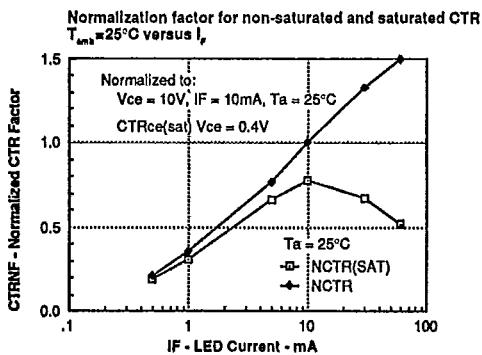
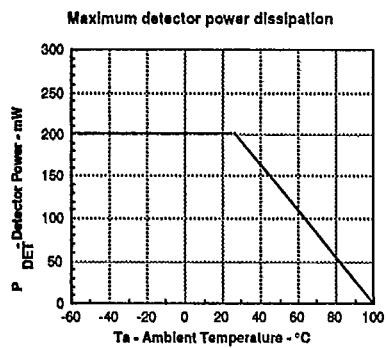
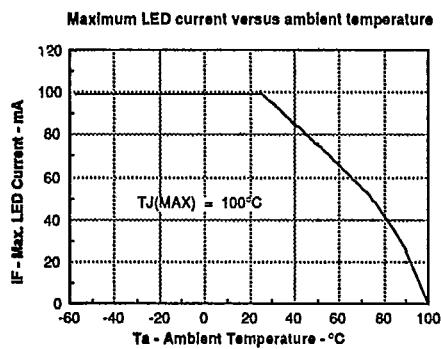
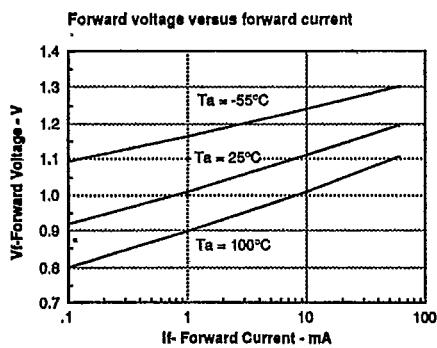
**SWITCHING TIMES****Non-Saturated Switching****Saturated Switching**

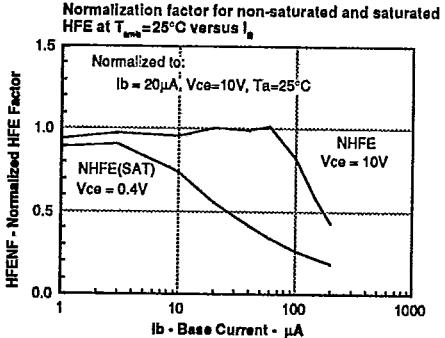
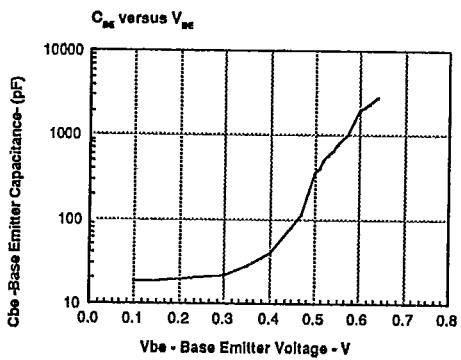
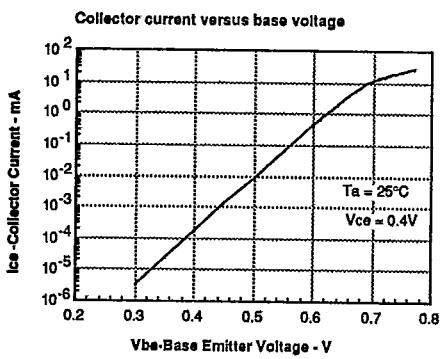
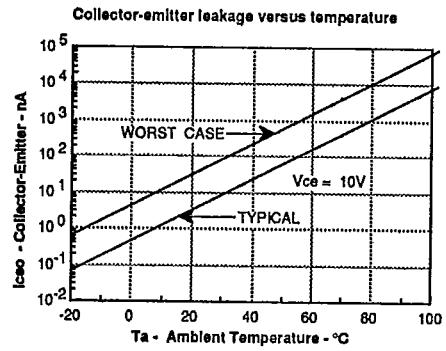
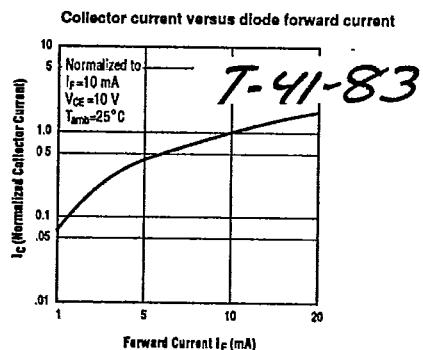
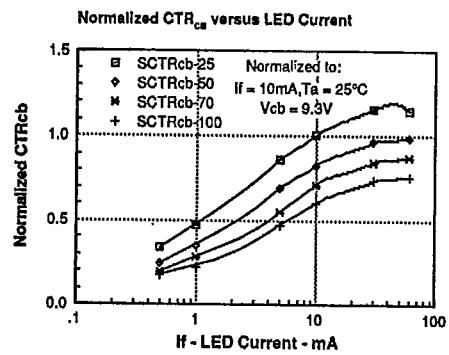
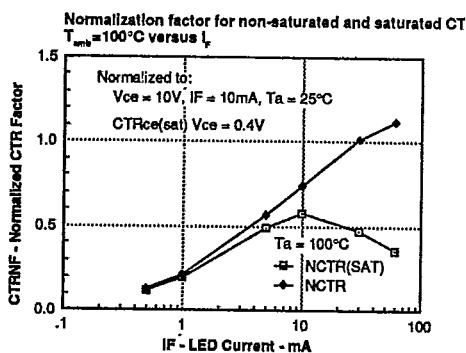
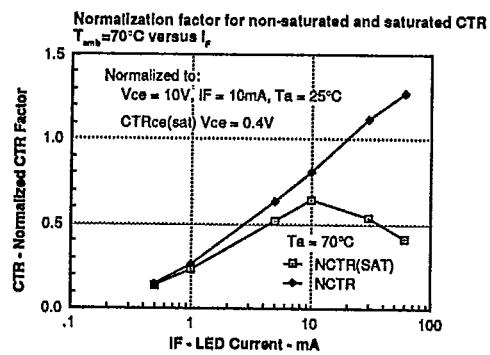
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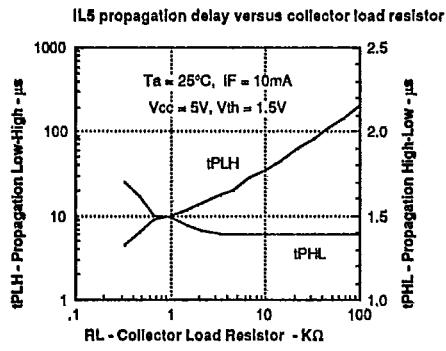
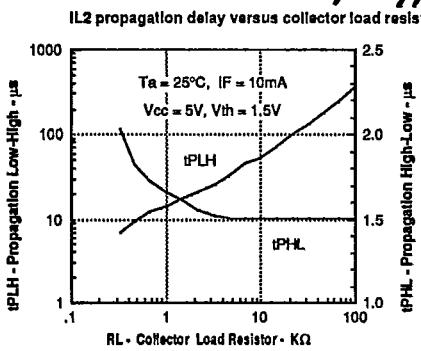
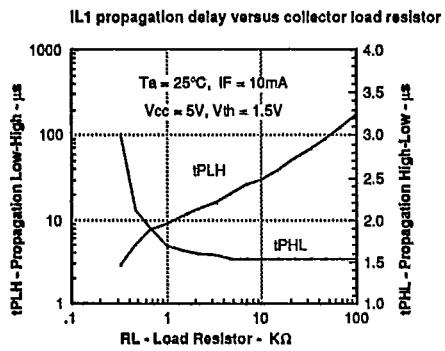
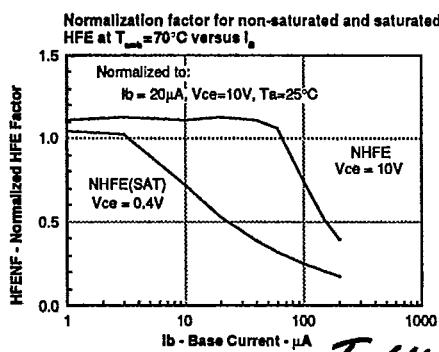
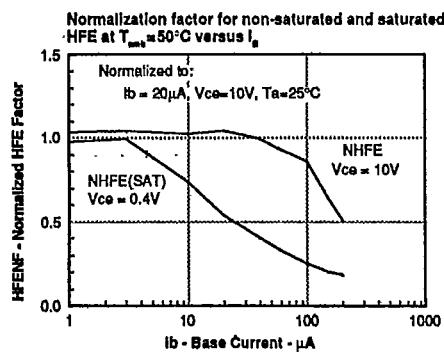
**Non-Saturated Switching Timing****Saturated Switching Timing**

Characteristic	$I_F=20\text{ mA}$	$I_F=5\text{ mA}$	$I_F=10\text{ mA}$	Unit
Delay $T_D$	0.8	1.7	1.7	$\mu\text{s}$
Rise Time ( $V_{cc}=5\text{ V}$ ) $t_R$	1.9	2.6	2.6	$\mu\text{s}$
Storage ( $R_L=75\ \Omega$ ) $t_S$	0.2	0.4	0.4	$\mu\text{s}$
Fall Time $t_F$	1.4	2.2	2.2	$\mu\text{s}$
Propagation H-L ( $50\%$ of $V_{cc}$ ) $t_{PLH}$	0.7	1.2	1.1	$\mu\text{s}$
Propagation L-H $t_{PHL}$	1.4	2.3	2.5	$\mu\text{s}$

Characteristic	$I_F=20\text{ mA}$	$I_F=5\text{ mA}$	$I_F=10\text{ mA}$	Unit
Delay $T_D$	0.8	1	1.7	$\mu\text{s}$
Rise Time ( $V_{ce}=0.4\text{ V}$ ) $t_R$	1.2	2	7	$\mu\text{s}$
Storage ( $R_L=1\text{ k}\Omega$ ) $t_S$	7.4	5.4	4.6	$\mu\text{s}$
Fall Time ( $V_{cc}=5\text{ V}$ ) $t_F$	7.6	13.5	20	$\mu\text{s}$
Propagation H-L ( $V_{cc}=1.5\text{ V}$ ) $t_{PLH}$	1.6	5.4	2.6	$\mu\text{s}$
Propagation L-H $t_{PHL}$	8.6	7.4	7.2	$\mu\text{s}$







Optocouplers  
(Optoisolators)